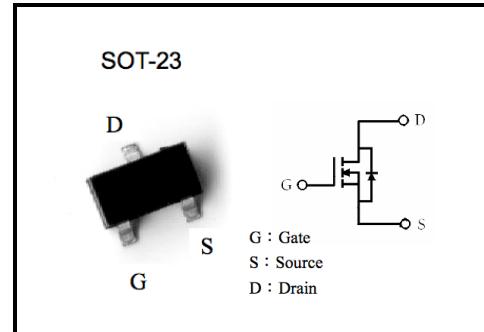


**30V N-Channel Logic Level Enhancement Mode MOSFET Product Specification
MSB55N03N3**

• FEATURES:

- V_{DS}=30V
- R_{DSON}=55mΩ @ V_{GS}=10V, I_D=3.5A
- R_{DSON}=85mΩ @ V_{GS}=4.5V, I_D=2A
- Lower gate charge
- Pb-free lead plating and Halogen-free package

BV_{DSS} : 30V
R_{DSON} : 55mΩ (typ.)
I_D : 3.5A



Absolute Maximum Ratings (T_c=25°C, unless otherwise noted)

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	V _{DS}	30	V
Gate-Source Voltage	V _{GS}	±20	V
Continuous Drain Current	I _D	3.5	A
		2.4	
Pulsed Drain Current	I _{DM}	14 (Note 1 & 2)	A
Power Dissipation	P _D	1.5 (Note 3)	W
		1 (Note 3)	
Thermal Resistance, Junction to Ambient	R _{th, j-a}	100 (Note 3)	°C/W
Operating Junction and Storage Temperature	T _j , T _{stg}	-55 ~ +175	°C

Note : 1. Pulse width limited by maximum junction temperature

2. Duty cycle ≤ 1%

3. Surface mounted on 1 in² copper pad of FR4 board; 270°C/W when mounted on min. copper pad

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Electrical Characteristics ($T_A=25^\circ\text{C}$, unless otherwise specified)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions
Static					
BV_{DSS}	30	-	-	V	$\text{V}_{\text{GS}}=0, \text{I}_D=250\mu\text{A}$
$\text{V}_{\text{GS(th)}}$	1	1.5	3	V	$\text{V}_{\text{DS}}=\text{V}_{\text{GS}}, \text{I}_D=250\mu\text{A}$
I_{GSS}	-	-	± 100	nA	$\text{V}_{\text{GS}}=\pm 20\text{V}, \text{V}_{\text{DS}}=0$
I_{DSS}	-	-	1	μA	$\text{V}_{\text{DS}}=24\text{V}, \text{V}_{\text{GS}}=0$
	-	-	10	μA	$\text{V}_{\text{DS}}=20\text{V}, \text{V}_{\text{GS}}=0, \text{T}_j=125^\circ\text{C}$
I_{DON}^1	3.5	-	-	A	$\text{V}_{\text{DS}}=5\text{V}, \text{V}_{\text{GS}}=10\text{V}$
$*\text{R}_{\text{DS(ON)}}^1$	-	45	55	$\text{m}\Omega$	$\text{I}_D=3.5\text{A}, \text{V}_{\text{GS}}=10\text{V}$
	-	65	85		$\text{I}_D=2\text{A}, \text{V}_{\text{GS}}=4.5\text{V}$
$*\text{G}_{\text{FS}}^1$	-	5	-	S	$\text{V}_{\text{DS}}=5\text{V}, \text{I}_D=3.5\text{A}$
Dynamic					
C_{iss}	-	319	-	pF	$\text{V}_{\text{DS}}=10\text{V}, \text{V}_{\text{GS}}=0, f=1\text{MHz}$
C_{oss}	-	66	-		
Cr_{ss}	-	53	-		
$*\text{t}_{\text{d(ON)}}^{1 \text{--} 2}$	-	8	-	ns	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_D=1\text{A}, \text{V}_{\text{GS}}=10\text{V}, \text{R}_G=6\Omega$
$*\text{t}_{\text{r}}^{1 \text{--} 2}$	-	2.5	-		
$*\text{t}_{\text{d(OFF)}}^{1 \text{--} 2}$	-	20	-		
$*\text{t}_{\text{f}}^{1 \text{--} 2}$	-	5	-		
$*\text{Q}_{\text{g}}^{1 \text{--} 2}$	-	6	-	nC	$\text{V}_{\text{DS}}=10\text{V}, \text{I}_D=3.5\text{A}, \text{V}_{\text{GS}}=4.5\text{V}$
$*\text{Q}_{\text{gs}}^{1 \text{--} 2}$	-	0.8	-		
$*\text{Q}_{\text{gd}}^{1 \text{--} 2}$	-	1.8	-		
Source-Drain Diode					
I_{s}	-	-	2	A	$\text{I}_{\text{F}}=\text{I}_{\text{s}}, \text{V}_{\text{GS}}=0\text{V}$
I_{SM}^3	-	-	8		
V_{SD}^1	-	-	1.2	V	$\text{I}_{\text{F}}=\text{I}_{\text{s}}, \text{V}_{\text{GS}}=0\text{V}$

¹ Pulse test : Pulse width $\leq 300\mu\text{s}$, Duty cycle $\leq 2\%$

² Independent of operating temperature

³ Pulse width limited by maximum junction temperature

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Typical Characteristics

